

Information Disclosure Statement

Sheet 1 of 2

Application Number:

10/628011

Filing Date

07/24/2003

First Named Inventor Group Art Unit

K. Tang

Examiner

1771 N. A.

Atty. Docket Num.

HSJ920030090US1

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Examiner Signature	This M. Rots	Date Considered	11/8/14

Sheet 2 of 2



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